Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/569,481	IWASA ET AL.	
Examiner	Art Unit	
Huyen Le	3751	

	SEAR	CHED	
Class	Subclass	Date	Examiner
401	192 196 198 199 202 205 207	6/4/2010	HL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
401	192	6/5/2010	HL
	198		
	196		

SEARCH N (INCLUDING SEARC	OTES CH STRATEGY	')
	DATE	EXMR